## Search Notes



# Application/Control No.

10736923

Reexamination
CHAN ET AL.

Applicant(s)/Patent Under

Examiner

Art Unit

Gauthier, Gerald

2614

## SEARCHED

Class	Subclass	Date	Examiner
379	88.18	8/29/2007	GG
219	132	2/25/2008	GG
379	88.18, 88.23, 221.09	11/20/2008	GG
704	270.1	11/20/2008	GG
709	227	11/20/2008	GG

### **SEARCH NOTES**

Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	8/29/2007	GG
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	2/25/2008	GG
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	11/20/2008	GG
Inventor' Name Search	11/20/2008	GG

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
379	88.18, 88.23, 221.09	11/20/2008	GG
704	270.1	11/20/2008	GG
709	227	11/20/2008	GG
	Interference Search History (see attached)	11/20/2008	GG

/Gerald Gauthier/ Primary Examiner.Art Unit 2614